## Notice of References Cited Application/Control No. 10/675,343 Examiner John A. Tweel, Jr. Applicant(s)/Patent Under Reexamination OESTERLING ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,025,776	02-2000	Matsuura, Yuuichirou	340/438
	В	US-6,006,146	12-1999	Usui et al.	701/29
	С	US-6,677,854	01-2004	Dix, Peter J.	340/438
	D	US-6,807,469	10-2004	Funkhouser et al.	701/33
	E	US-6,819,236	11-2004	Kawai et al.	340/539.24
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	s					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.